

Search Notes



Application/Control No.

10/721,745

Examiner

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Applicant(s)/Patent under
Reexamination

HEDLER ET AL.

Art Unit

2813

SEARCHED

Class	Subclass	Date	Examiner
438	106 108	4/12/05	yt
	612 → 614		
	123		
	116		
	124 → 127		
257	778	4/13/05	
	738		
	781		
	668		
	680		
	747		
	737		
	795		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
S. East/West USPAT EPO JPO Derwent IBMT DB	4/13/05	yt